Searc	ch Notes	

Application/Control No.	Applicant(s)/Patent (Reexamination	under
10/721,410	CHENG ET AL.	
Examiner	Art Unit	
Suk lin Kana	2616	

SEARCHED			
Class	Subclass	Date	Examiner
370	508	7/31/2007	sJK′
370	321	7/31/2007	SJK
370	322	7/31/2007	SJK
370	324	7/31/2007	SJK
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
EAST image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	7/31/2007	SJK	
Inventor name and Assignee search in PALM ExPO and EAST	7/31/2007	sjk	
Consulted with Chau Nguyen (SPE)	7/31/2007	sjk	
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